Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/720,336	BAE, BYOUNG-YOUNG
Examiner	Art Unit

Brian E. Miller

2627

SEARCHED					
Class	Subclass	Date	Examiner		
			Examiner		
720	652,653	4/25/2006	ВЕМ		
720	601	4/25/2006	ВЕМ		
		-			

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
	1				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST Search (enclosed)	4/25/2006	ВЕМ	
PLUS search	4/25/2006	ВЕМ	